The 2008 International End-User Virtualization (EUV-08)

End-User Virtualization technology is important for end-users, which provides a convenient and easy environment. It is a new attractive topic in the computer related research areas in recent years. There are still many unsolved problems that hold up its development, including how to provide record, replay and migration characteristics for Virtual Desktop Environment (VDE), how to design the collaborations of multiple VDEs, and what the novel applications are for VDE. All of these set a great barrier for further research. Moreover, in the pervasive and ubiquitous environment, for embedded and ubiquitous computing technologies, how to play important roles for the virtual desktop environment is not clear.

This workshop will support an opportunity for industry and academic professionals to discuss the latest issues and progress in the area of end-user virtualization. The workshop will publish high quality papers which are closely related to the various theories and practical applications in end-user virtualization. Furthermore, we hope that this workshop will provide us with a good chance to share creative ideas regarding end-user virtualization with other researchers and engineers from institutions around the world. EUV’08 will emphasize the theory, method, and design of embedded and ubiquitous computing in desktop level.

While EUV2008 is the 1st workshop for end-user virtualization, this year we have 19 papers initially submitted to this workshop and each paper has been carefully reviewed by the internationally organized EUV2008 Technical Program Committee (TPC) members – 3 reviewers for each paper. We selected only excellent 7 papers among them. We congratulate the authors of accepted papers and regret a lot of high quality submissions could not be included, due to the limit in session organization.

On behalf of the board of EUV2008 workshop, we appreciate for all the submission authors to the program. We would like to thank the TPC members and external reviewers for their efforts in reviewing the submissions. Finally, we would like to thank Prof. Zhijun Wang (Hong Kong Polytechnic Univ., Hong Kong) and Prof. Dakai Zhu (Univ. of Texas at San Antonio, USA), the workshop co-chair, for the guidance in the organization of this workshop.

I hope you all enjoy this workshop and Shanghai, China

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